











SN74AUP1G34

SCES603K - AUGUST 2004 - REVISED OCTOBER 2014

# SN74AUP1G34 Low-Power Single Buffer Gate

#### **Features**

- Available in the Ultra Small 0.64 mm<sup>2</sup> Package (DPW) with 0.5-mm Pitch
- Low Static-Power Consumption;  $I_{CC} = 0.9 \mu A Max$
- Low Dynamic-Power Consumption;  $C_{pd} = 4.1 \text{ pF Typ at } 3.3 \text{ V}$
- Low Input Capacitance;  $C_i = 1.5 pF Typ$
- Low Noise Overshoot and Undershoot < 10% of  $V_{CC}$
- Ioff Supports Live Insertion, Partial Power Down Mode, and Back Drive Protection
- Input Hysteresis Allows Slow Input Transition and Better Switching Noise Immunity at the Input  $(V_{hys} = 250 \text{ mV Typ at } 3.3 \text{ V})$
- Wide Operating V<sub>CC</sub> Range of 0.8 V to 3.6 V
- Optimized for 3.3-V Operation
- 3.6-V I/O Tolerant to Support Mixed-Mode Signal Operation
- $t_{pd} = 4.1 \text{ ns Max at } 3.3 \text{ V}$
- Suitable for Point-to-Point Applications
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Performance Tested Per JESD 22
  - 2000-V Human-Body Model (A114-B, Class II)
  - 1000-V Charged-Device Model (C101)

# 2 Applications

- **ATCA Solutions**
- Active Noise Cancellation (ANC)
- Barcode Scanner
- **Blood Pressure Monitor**
- **CPAP Machine**
- Cable Solutions
- DLP 3D Machine Vision, Hyperspectral Imaging, Optical Networking, and Spectroscopy
- E-Book
- Embedded PC
- Field Transmitter: Temperature or Pressure Sensor
- **Fingerprint Biometrics**
- HVAC: Heating, Ventilating, and Air Conditioning
- Network-Attached Storage (NAS)
- Server Motherboard and PSU
- Software Defined Radio (SDR)
- TV: High-Definition (HDTV), LCD, and Digital
- Video Communications System
- Wireless Data Access Card, Headset, Keyboard, Mouse, and LAN Card
- X-ray: Baggage Scanner, Medical, and Dental

# 3 Description

This single buffer gate performs the Boolean function Y = A in positive logic.

## Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)		
	SOT (5)	1.60 mm × 1.20 mm		
SN74AUP1G34	USON (6)	1.45 mm × 1.00 mm		
SIN/4AUP IG34	X2SON (4)	0.80 mm × 0.80 mm		
	DSBGA (4)	0.79 mm × 0.79 mm		

(1) For all available packages, see the orderable addendum at the end of the data sheet.

# Simplifed Schematic



Features ...... 1



Pulse Width......8

# **Table of Contents**

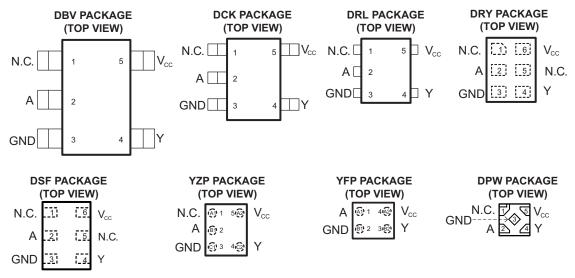
2	Applications	1		8.2 Enable and Disable Times	9
3	Description		9	Detailed Description	10
4	Simplifed Schematic			9.1 Overview	
5	Revision History			9.2 Functional Block Diagram	
6	Pin Configuration and Function			9.3 Feature Description	
7	Specifications			9.4 Device Functional Modes	
	7.1 Absolute Maximum Ratings		10	Application and Implementation	
	7.2 Handling Ratings			10.1 Application Information	
	7.3 Recommended Operating Conditions	4		10.2 Typical Application	
	7.4 Thermal Information			Power Supply Recommendations	
	7.5 Electrical Characteristics	5	12	Layout	
	7.6 Switching Characteristics, C <sub>L</sub> = 5 pF	5		12.1 Layout Guidelines	
	7.7 Switching Characteristics, C <sub>L</sub> = 10 pF	6		12.2 Layout Example	
	7.8 Switching Characteristics, C <sub>L</sub> = 15 pF	6	13	Device and Documentation Support	
	7.9 Switching Characteristics, C <sub>L</sub> = 30 pF	6		13.1 Trademarks	
	7.10 Operating Characteristics			13.2 Electrostatic Discharge Caution	
	7.11 Typical Characteristics			13.3 Glossary	13
8	Parameter Measurement Information		14	Mechanical, Packaging, and Orderable Information	13
	nges from Revision J (June 2014) to Revision K				Page
	Jpdated Device Information tablenges from Revision I (November 2012) to Revisi				Page
• (	Jpdated document to new TI data sheet format				1
• [	Deleted Ordering Information table				1
• (					
	Jpdated Description				1
	·				
<ul> <li>A</li> </ul>	Added Device Information table				1
	Added Device Information table				1 4
• /	Added Device Information table.  Added Handling Ratings table.  Added Thermal Information table.				1 4 4
• /	Added Device Information table				1 4 4
• A	Added Device Information table.  Added Handling Ratings table.  Added Thermal Information table.				1 4 4

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## 6 Pin Configuration and Function



N.C. - No internal connection

See mechanical drawings for dimensions.

#### **Pin Functions**

			PIN				
NAME	DBV, DCK, DRL	DSF, DRY	YFP	DPW	YFP	I/O	DESCRIPTION
NC	1	1, 5	-	1		_	No connect
Α	2	2	A1	2	A1	I	Input A
GNY	3	3	B1	3	B1	_	Ground
Υ	4	4	B2	4	B2	0	Output Y
V <sub>CC</sub>	5	6	A2	5	A2	_	Power Pin

# 7 Specifications

# 7.1 Absolute Maximum Ratings<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range		-0.5	4.6	V
VI	Input voltage range <sup>(2)</sup>		-0.5	4.6	V
Vo	Voltage range applied to any output in the hig	-0.5	4.6	V	
Vo	Output voltage range in the high or low state	-0.5	V <sub>CC</sub> + 0.5	V	
I <sub>IK</sub>	Input clamp current	V <sub>I</sub> < 0		-50	mA
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0		<b>-</b> 50	mA
Io	Continuous output current	Continuous output current			
	Continuous current through V <sub>CC</sub> or GND			±50	mA

<sup>1)</sup> Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

<sup>(2)</sup> The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.



# 7.2 Handling Ratings

			MIN	MAX	UNIT
T <sub>stg</sub>	Storage temperature rang	e	-65	150	°C
V	V <sub>(ESD)</sub> Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins <sup>(1)</sup>		2000	V
V(ESD)		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins (2)	0	1000	V

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

# 7.3 Recommended Operating Conditions<sup>(1)</sup>

	, 5		MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage		0.8	3.6	V
		V <sub>CC</sub> = 0.8 V	V <sub>CC</sub>		
.,	High lavel input valtage	V <sub>CC</sub> = 1.1 V to 1.95 V	0.65 × V <sub>CC</sub>		V
$V_{IH}$	High-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.6		V
		V <sub>CC</sub> = 3 V to 3.6 V	2		
		V <sub>CC</sub> = 0.8 V		0	
.,	Low level input voltage	V <sub>CC</sub> = 1.1 V to 1.95 V		0.35 × V <sub>CC</sub>	V
$V_{IL}$	Low-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		0.7	V
		V <sub>CC</sub> = 3 V to 3.6 V		0.9	
VI	Input voltage		0	3.6	V
Vo	Output voltage		0	V <sub>CC</sub>	V
		V <sub>CC</sub> = 0.8 V		-20	μΑ
		V <sub>CC</sub> = 1.1 V		-1.1	
(2)	Libely level evident eviment	V <sub>CC</sub> = 1.4 V		-1.7	
I <sub>OH</sub> (2)	High-level output current	V <sub>CC</sub> = 1.65 V		-1.9	mA
		V <sub>CC</sub> = 2.3 V		-3.1	
		V <sub>CC</sub> = 3 V		-4	
		V <sub>CC</sub> = 0.8 V		20	μΑ
		V <sub>CC</sub> = 1.1 V		1.1	
(2)	Laveland autout anneat	V <sub>CC</sub> = 1.4 V		1.7	
I <sub>OL</sub> (2)	Low-level output current	V <sub>CC</sub> = 1.65 V		1.9	mA
	·	V <sub>CC</sub> = 2.3 V		3.1	
		V <sub>CC</sub> = 3 V		4	
Δt/Δν	Input transition rise or fall rate	V <sub>CC</sub> = 0.8 V to 3.6 V		200	ns/V
T <sub>A</sub>	Operating free-air temperature		-40	85	°C

<sup>(1)</sup> All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

# 7.4 Thermal Information

	······································						
	THERMAL METRIC <sup>(1)</sup>	DBV	DCK	DRL	DSF	DRY	LINUT
	THERMAL METRIC	5 PINS	5 PINS	5 PINS	6 PINS	6 PINS	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance	271.4	338.4	349.7	407.1	554.9	
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	213.5	110.6	120.5	232.0	385.4	
$R_{\theta JB}$	Junction-to-board thermal resistance	108.2	118.8	171.4	306.9	388.2	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	89.3	3.0	10.8	40.3	159.0	
$\Psi_{JB}$	Junction-to-board characterization parameter	107.6	117.8	169.4	306.0	384.1	

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.

<sup>(2)</sup> Defined by the signal integrity requirements and design goal priorities



### 7.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEOT CONDITI	TEST COMPITIONS		TA	= 25°C		$T_A = -40^{\circ}C$				
PARAMETER	TEST CONDITION	ONS	V <sub>CC</sub>	MIN	TYP	MAX	MIN	MAX	UNIT		
	I <sub>OH</sub> = -20 μA		0.8 V to 3.6 V	V <sub>CC</sub> - 0.1			V <sub>CC</sub> - 0.1				
	$I_{OH} = -1.1 \text{ mA}$		1.1 V	0.75 × V <sub>CC</sub>			0.7 × V <sub>CC</sub>				
	$I_{OH} = -1.7 \text{ mA}$		1.4 V	1.11			1.03				
W	$I_{OH} = -1.9 \text{ mA}$		1.65 V	1.32			1.3		V		
V <sub>OH</sub>	$I_{OH} = -2.3 \text{ mA}$		2.3 V	2.05			1.97		V		
	$I_{OH} = -3.1 \text{ mA}$			1.9			1.85				
	$I_{OH} = -2.7 \text{ mA}$		3 V	2.72			2.67				
	$I_{OH} = -4 \text{ mA}$			2.6			2.55				
	I <sub>OL</sub> = 20 μA		0.8 V to 3.6 V			0.1		0.1			
	I <sub>OL</sub> = 1.1 mA		1.1 V			0.3 × V <sub>CC</sub>		0.3 × V <sub>CC</sub>			
	I <sub>OL</sub> = 1.7 mA		1.4 V			0.31		0.37			
<b>V</b>	I <sub>OL</sub> = 1.9 mA		1.65 V			0.31		0.35	V		
$V_{OL}$	$I_{OL} = 2.3 \text{ mA}$		221/			0.31		0.33	V		
	$I_{OL} = 3.1 \text{ mA}$		2.3 V			0.44		0.45			
	$I_{OL} = 2.7 \text{ mA}$		3 V			0.31		0.33			
	$I_{OL} = 4 \text{ mA}$		3 V			0.44		0.45			
I <sub>I</sub> A input	$V_I = GND \text{ to } 3.6 \text{ V}$		0 V to 3.6 V			0.1		0.5	μΑ		
l <sub>off</sub>	$V_{1} \text{ or } V_{O} = 0 \text{ V to}$ 3.6 V		0 V			0.2		0.6	μΑ		
$\Delta I_{\text{off}}$	$V_{1} \text{ or } V_{O} = 0 \text{ V to}$ 3.6 V		0 V to 0.2 V			0.2		0.6	μΑ		
I <sub>CC</sub>	$V_I = GND \text{ or}$ ( $V_{CC} \text{ to } 3.6 \text{ V}$ )	I <sub>O</sub> = 0	0.8 V to 3.6 V			0.5		0.9	μΑ		
Δl <sub>CC</sub>	$V_{I} = V_{CC} - 0.6 \text{ V}$	I <sub>O</sub> = 0	3.3 V			40		50	μΑ		
C	V V or CND		0 V		1.5				~F		
C <sub>i</sub>	$V_I = V_{CC}$ or GND		3.6 V		1.5				pF		
C <sub>o</sub>	V <sub>O</sub> = GND		0 V		2.5				pF		

# 7.6 Switching Characteristics, $C_L = 5 pF$

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3 and Figure 4)

PARAMETER	FROM	TO (OUTPUT)	V <sub>CC</sub>	T <sub>A</sub> = 25°C			$T_A = -40$ °C t	UNIT	
PARAMETER	(INPUT)			MIN	TYP	MAX	MIN	MAX	UNIT
			0.8 V	1.8	14.5	27.4			
		Y	$1.2 \text{ V} \pm 0.1 \text{ V}$	3	5.6	11.2	0.4	13.9	
•	А		1.5 V ± 0.1 V	2.5	4	7.2	0.7	9.2	
t <sub>pd</sub>			1.8 V ± 0.15 V	2.2	3.2	6	0.8	7.3	ns
			$2.5 \text{ V} \pm 0.2 \text{ V}$	1.8	2.4	3.9	0.6	5.1	
			$3.3 \text{ V} \pm 0.3 \text{ V}$	1.4	2	3.2	0.6	4.1	



# 7.7 Switching Characteristics, $C_L = 10 pF$

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3 and Figure 4

DADAMETED	ARAMETER FROM TO		V	T,	4 = 25°C		$T_A = -40$ °C	UNIT	
PARAMETER	(INPUT)	(OUTPUT)	V <sub>CC</sub>	MIN	TYP	MAX	MIN	MAX	UNII
		0.8 V	2.7	16.6	28.2				
		1.2 V ± 0.1 V	3.6	6.6	12.7	0.3	15.4		
	^	Υ	1.5 V ± 0.1 V	3	4.8	8.3	1.2	10.3	no
<sup>L</sup> pd	t <sub>pd</sub> A		1.8 V ± 0.15 V	2.7	3.9	6.9	1.3	8.3	ns
			2.5 V ± 0.2 V	2.3	2.9	4.5	1.2	5.8	
			3.3 V ± 0.3 V	2	2.4	3.8	1.1	4.8	

# 7.8 Switching Characteristics, $C_L = 15 pF$

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3 and Figure 4

PARAMETER	FROM	TO (OUTPUT)	.,	T,	<sub>λ</sub> = 25°C		T <sub>A</sub> = -40°C	UNIT	
TANAMETER (I	(INPUT)		V <sub>cc</sub>	MIN	TYP	MAX	MIN	MAX	UNIT
			0.8 V	5.1	18.6	30.2			
		1.2 V ± 0.1 V	4.3	7.5	13.6	1.3	16.5		
4	^	Υ	1.5 V ± 0.1 V	3.6	5.5	9	1.9	11.2	20
t <sub>pd</sub>	A		1.8 V ± 0.15 V	3.2	4.5	7.5	1.9	8.9	ns
		2.5 V ± 0.2 V	2.6	3.4	5.2	1.7	6.5		
			3.3 V ± 0.3 V	2.3	2.9	4.2	1.5	5	

# 7.9 Switching Characteristics, $C_L = 30 pF$

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3 and Figure 4

PARAMETER	FROM	TO (OUTPUT)	V	T <sub>A</sub> = 25°C			$T_A = -40$ °C to 85°C		UNIT
TANAMETER	(INPUT)		V <sub>cc</sub>	MIN	TYP	MAX	MIN	MAX	UNIT
		0.8 V	9.9	24.2	36.3				
		Y	1.2 V ± 0.1 V	6.3	10.1	16.3	3.6	18.9	
	^		1.5 V ± 0.1 V	5.1	7.4	11	3.4	13	
t <sub>pd</sub> A	A		1.8 V ± 0.15 V	4.5	6.1	9.3	3.2	10.6	ns
			2.5 V ± 0.2 V	3.7	4.7	6.4	2.7	7.8	
			3.3 V ± 0.3 V	3.3	4	5.3	2.5	6.5	

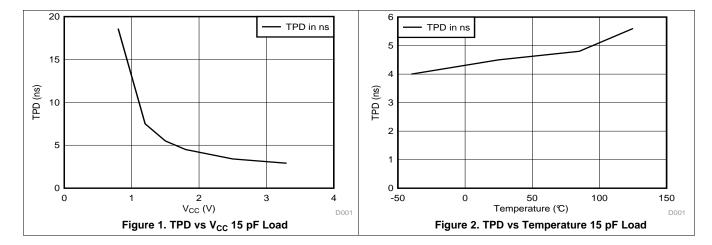
# 7.10 Operating Characteristics

 $T_A = 25^{\circ}C$ 

	PARAMETER	TEST CONDITIONS	V <sub>CC</sub>	TYP	UNIT
			0.8 V	3.8	
			1.2 V ± 0.1 V	3.8	
	Dower discipation conscitones	f 40 MHz	1.5 V ± 0.1 V	3.8	~F
C <sub>pd</sub>	Power dissipation capacitance	f = 10 MHz	1.8 V ± 0.15 V	3.8	pF
			2.5 V ± 0.2 V	3.9	
			3.3 V ± 0.3 V	4.1	



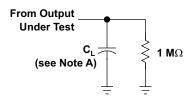
# 7.11 Typical Characteristics





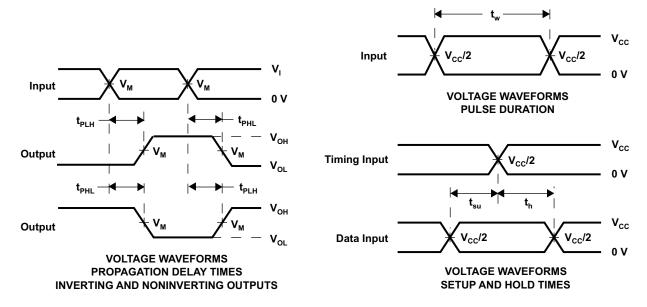
### 8 Parameter Measurement Information

### 8.1 Propagation Delays, Setup and Hold Times, and Pulse Width



**LOAD CIRCUIT** 

	V <sub>CC</sub> = 0.8 V	V <sub>CC</sub> = 1.2 V ± 0.1 V	V <sub>cc</sub> = 1.5 V ± 0.1 V	V <sub>cc</sub> = 1.8 V ± 0.15 V	$ m V_{CC}$ = 2.5 V $\pm$ 0.2 V	V <sub>CC</sub> = 3.3 V ± 0.3 V
C <sub>L</sub>	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF
V <sub>M</sub>	V <sub>CC</sub> /2	V <sub>cc</sub> /2	V <sub>cc</sub> /2	V <sub>cc</sub> /2	V <sub>CC</sub> /2	V <sub>CC</sub> /2
V <sub>I</sub>	V <sub>CC</sub>	V <sub>cc</sub>	V <sub>cc</sub>	V <sub>cc</sub>	V <sub>CC</sub>	V <sub>CC</sub>



- NOTES: A. C<sub>L</sub> includes probe and jig capacitance.
  - B. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 Mhz,  $Z_{\Omega}$  = 50  $\Omega$ ,  $t_r/t_f$  = 3 ns.
  - C. The outputs are measured one at a time, with one transition per measurement.
  - D.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .
  - E. All parameters and waveforms are not applicable to all devices.

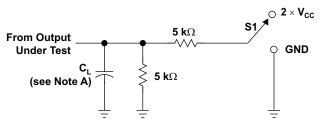
Figure 3. Load Circuit and Voltage Waveforms

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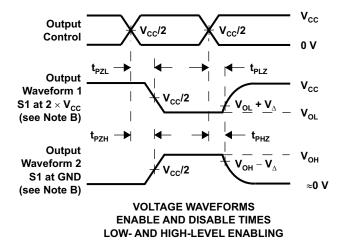
#### 8.2 Enable and Disable Times



TEST	S1
t <sub>PLZ</sub> /t <sub>PZL</sub>	2 × V <sub>CC</sub>
t <sub>PHZ</sub> /t <sub>PZH</sub>	GND

**LOAD CIRCUIT** 

	V <sub>CC</sub> = 0.8 V	V <sub>cc</sub> = 1.2 V ± 0.1 V	V <sub>cc</sub> = 1.5 V ± 0.1 V	V <sub>CC</sub> = 1.8 V ± 0.15 V	V <sub>cc</sub> = 2.5 V ± 0.2 V	V <sub>CC</sub> = 3.3 V ± 0.3 V
C <sub>L</sub> V <sub>M</sub> V <sub>I</sub> V <sub>∆</sub>	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF
	V <sub>cc</sub> /2	V <sub>cc</sub> /2	V <sub>cc</sub> /2	V <sub>cc</sub> /2	V <sub>cc</sub> /2	V <sub>cc</sub> /2
	V <sub>cc</sub>	V <sub>cc</sub>	V <sub>cc</sub>	V <sub>cc</sub>	V <sub>cc</sub>	V <sub>cc</sub>
	0.1 V	0.1 V	0.1 V	0.15 V	0.15 V	0.3 V



NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50 \Omega$ ,  $t/t_f = 3$  ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
- G. All parameters and waveforms are not applicable to all devices.

Figure 4. Load Circuit and Voltage Waveforms



## 9 Detailed Description

#### 9.1 Overview

This single buffer gate operates from 0.8 V to 3.6 V and performs the Boolean function Y = A in positive logic. The AUP family of devices has quiescent power consumption less than 1  $\mu$ A and comes in the ultra small DPW package. The DPW package technology is a major breakthrough in IC packaging. Its tiny 0.64 mm square footprint saves significant board space over other package options while still retaining the traditional manufacturing friendly lead pitch of 0.5 mm.

This device is fully specified for partial-power-down applications using  $I_{off}$ . The  $I_{off}$  circuitry disables the outputs, preventing damaging current back-flow through the device when it is powered. The  $I_{off}$  feature also allows for live insertion.

#### 9.2 Functional Block Diagram



### 9.3 Feature Description

- Wide operating V<sub>CC</sub> range of 0.8 V to 3.6 V
- 3.6-V I/O tolerant to support down translation
- Input hysteresis allows slow input transition and better switching noise immunity at the input
- I<sub>off</sub> feature allows voltages on the inputs and outputs when V<sub>CC</sub> is 0 V
- · Low noise due to slower edge rates

#### 9.4 Device Functional Modes

**Table 1. Function Table** 

INPUT A	OUTPUT Y
Н	Н
L	L



## 10 Application and Implementation

### 10.1 Application Information

The AUP family is TI's premier solution to the industry's low-power needs in battery-powered portable applications. This family ensures a very low static and dynamic power consumption across the entire  $V_{CC}$  range of 0.8 V to 3.6 V, resulting in an increased battery life. This product also maintains excellent signal integrity. It has a small amount of hysteresis built in allowing for slower or noisy input signals. The lowered drive produces slower edges and prevents overshoot and undershoot on the outputs.

The AUP family of single gate logic makes excellent translators for the new lower voltage Micro- processors that typically are powered from 0.8 V to 1.2 V. They can drop the voltage of peripheral drivers and accessories that are still powered by 3.3 V to the new uC power levels.

### 10.2 Typical Application

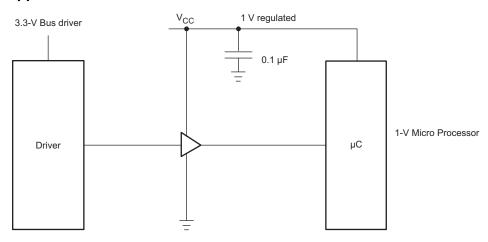


Figure 5. Typical Application

#### 10.2.1 Design Requirements

This device uses CMOS technology and has balanced output drive. Care should be taken to avoid bus contention because it can drive currents that would exceed maximum limits.

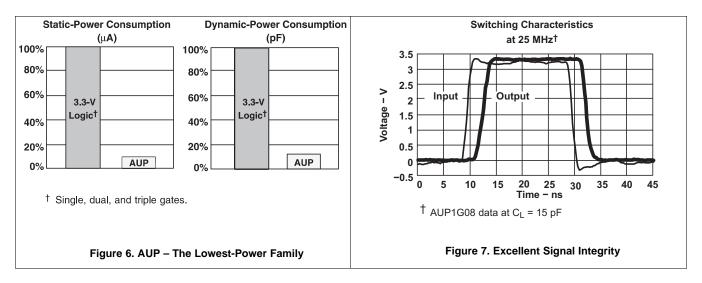
#### 10.2.2 Detailed Design Procedure

- 1. Recommended Input conditions
  - Rise time and fall time specifications. See (Δt/ΔV) in Recommended Operating Conditions table.
  - Specified high and low levels. See (V<sub>IH</sub> and V<sub>II</sub>) in Recommended Operating Conditions table.
  - Inputs are overvoltage tolerant allowing them to go as high as 3.6 V at any valid V<sub>CC</sub>
- 2. Recommend output conditions
  - Load currents should not exceed 20 mA on the output and 50 mA total for the part
  - Outputs should not be pulled above V<sub>CC</sub>



## **Typical Application (continued)**

#### 10.2.3 Application Curves



## 11 Power Supply Recommendations

The power supply can be any voltage between the Min and Max supply voltage rating located in the *Recommended Operating Conditions* table.

Each  $V_{CC}$  terminal should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, 0.1  $\mu$ F is recommended and if there are multiple  $V_{CC}$  terminals then .01  $\mu$ F or .022  $\mu$ F is recommended for each power terminal. It is ok to parallel multiple bypass caps to reject different frequencies of noise. A 0.1  $\mu$ F and 1  $\mu$ F are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results.

#### 12 Layout

### 12.1 Layout Guidelines

When using multiple bit logic devices inputs should not ever float.

In many cases, functions or parts of functions of digital logic devices are unused, for example, when only two inputs of a triple-input AND gate are used or only 3 of the 4 buffer gates are used. Such input pins should not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. Specified below are the rules that must be observed under all circumstances. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that should be applied to any particular unused input depends on the function of the device. Generally they will be tied to GND or  $V_{CC}$  whichever make more sense or is more convenient. It is generally OK to float outputs unless the part is a transceiver. If the transceiver has an output enable pin it will disable the outputs section of the part when asserted. This will not disable the input section of the I.O's so they also cannot float when disabled.

#### 12.2 Layout Example





# 13 Device and Documentation Support

#### 13.1 Trademarks

All trademarks are the property of their respective owners.

#### 13.2 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

# 13.3 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

# 14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

www.ti.com 6-Dec-2024

#### **PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
SN74AUP1G34DBVR	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	NIPDAU   SN	Level-1-260C-UNLIM	-40 to 85	H34R	Samples
SN74AUP1G34DBVT	ACTIVE	SOT-23	DBV	5	250	RoHS & Green	NIPDAU   SN	Level-1-260C-UNLIM	-40 to 85	H34R	Samples
SN74AUP1G34DCKR	ACTIVE	SC70	DCK	5	3000	RoHS & Green	NIPDAU   SN	Level-1-260C-UNLIM	-40 to 85	(H95, H9F, H9K, H9 R)	Samples
SN74AUP1G34DCKT	ACTIVE	SC70	DCK	5	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	(H95, H9R)	Samples
SN74AUP1G34DPWR	ACTIVE	X2SON	DPW	5	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	G4	Samples
SN74AUP1G34DRLR	ACTIVE	SOT-5X3	DRL	5	4000	RoHS & Green	NIPDAU   NIPDAUAG	Level-1-260C-UNLIM	-40 to 85	(H97, H9R)	Samples
SN74AUP1G34DRYR	ACTIVE	SON	DRY	6	5000	RoHS & Green	NIPDAU   NIPDAUAG	Level-1-260C-UNLIM	-40 to 85	H9	Samples
SN74AUP1G34DSFR	ACTIVE	SON	DSF	6	5000	RoHS & Green	NIPDAU   NIPDAUAG	Level-1-260C-UNLIM		H9	Samples
SN74AUP1G34YFPR	ACTIVE	DSBGA	YFP	4	3000	RoHS & Green	SNAGCU	Level-1-260C-UNLIM		H9 N	Samples
SN74AUP1G34YZPR	ACTIVE	DSBGA	YZP	5	3000	RoHS & Green	SNAGCU	Level-1-260C-UNLIM	-40 to 85	H9N	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.



# **PACKAGE OPTION ADDENDUM**

www.ti.com 6-Dec-2024

- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.



www.ti.com 25-Dec-2024

### **TAPE AND REEL INFORMATION**





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

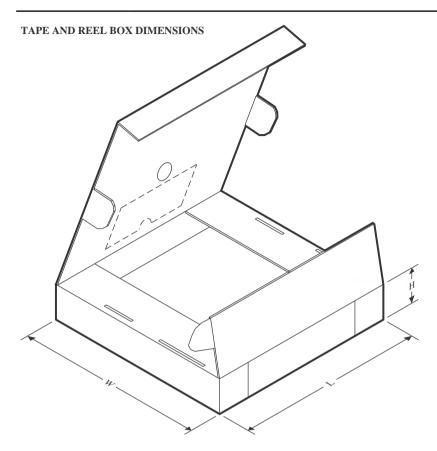


#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74AUP1G34DBVR	SOT-23	DBV	5	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
SN74AUP1G34DBVT	SOT-23	DBV	5	250	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
SN74AUP1G34DCKR	SC70	DCK	5	3000	180.0	8.4	2.3	2.5	1.2	4.0	8.0	Q3
SN74AUP1G34DCKT	SC70	DCK	5	250	178.0	9.2	2.4	2.4	1.22	4.0	8.0	Q3
SN74AUP1G34DPWR	X2SON	DPW	5	3000	178.0	8.4	0.91	0.91	0.5	2.0	8.0	Q3
SN74AUP1G34DRLR	SOT-5X3	DRL	5	4000	180.0	8.4	1.98	1.78	0.69	4.0	8.0	Q3
SN74AUP1G34DRYR	SON	DRY	6	5000	180.0	9.5	1.15	1.6	0.75	4.0	8.0	Q1
SN74AUP1G34DSFR	SON	DSF	6	5000	180.0	8.4	1.16	1.16	0.5	4.0	8.0	Q2
SN74AUP1G34YFPR	DSBGA	YFP	4	3000	178.0	9.2	0.89	0.89	0.58	4.0	8.0	Q1
SN74AUP1G34YZPR	DSBGA	YZP	5	3000	178.0	9.2	1.02	1.52	0.63	4.0	8.0	Q1



www.ti.com 25-Dec-2024



\*All dimensions are nominal

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Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74AUP1G34DBVR	SOT-23	DBV	5	3000	210.0	185.0	35.0
SN74AUP1G34DBVT	SOT-23	DBV	5	250	210.0	185.0	35.0
SN74AUP1G34DCKR	SC70	DCK	5	3000	210.0	185.0	35.0
SN74AUP1G34DCKT	SC70	DCK	5	250	180.0	180.0	18.0
SN74AUP1G34DPWR	X2SON	DPW	5	3000	205.0	200.0	33.0
SN74AUP1G34DRLR	SOT-5X3	DRL	5	4000	202.0	201.0	28.0
SN74AUP1G34DRYR	SON	DRY	6	5000	184.0	184.0	19.0
SN74AUP1G34DSFR	SON	DSF	6	5000	210.0	185.0	35.0
SN74AUP1G34YFPR	DSBGA	YFP	4	3000	220.0	220.0	35.0
SN74AUP1G34YZPR	DSBGA	YZP	5	3000	220.0	220.0	35.0





#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
  2. This drawing is subject to change without notice.
  3. Reference JEDEC MO-178.

- 4. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25 mm per side.
- 5. Support pin may differ or may not be present.





NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.





Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.









#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.





NOTES: (continued)

3. For more information, see QFN/SON PCB application report in literature No. SLUA271 (www.ti.com/lit/slua271).





NOTES: (continued)

Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.







#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. Reference JEDEC registration MO-287, variation X2AAF.





NOTES: (continued)

4. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).





4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



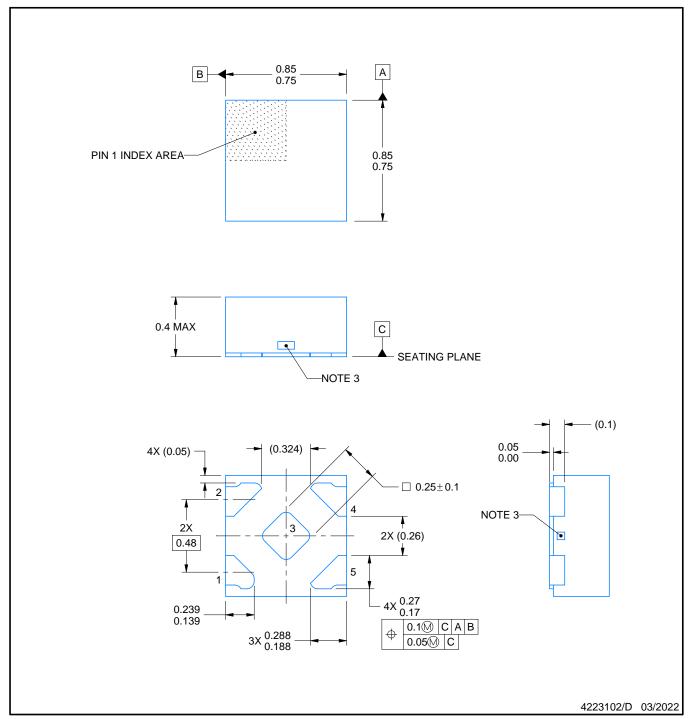


Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.

4211218-3/D





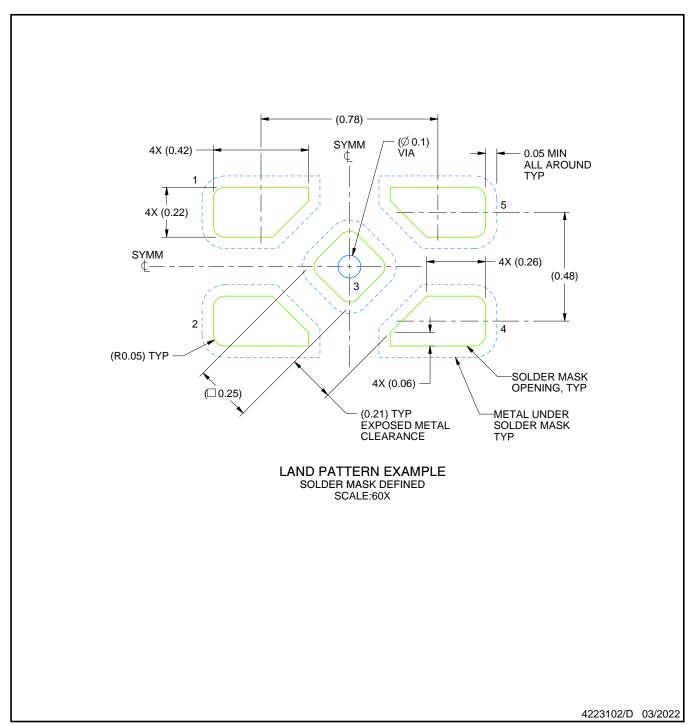


#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.
- 3. The size and shape of this feature may vary.

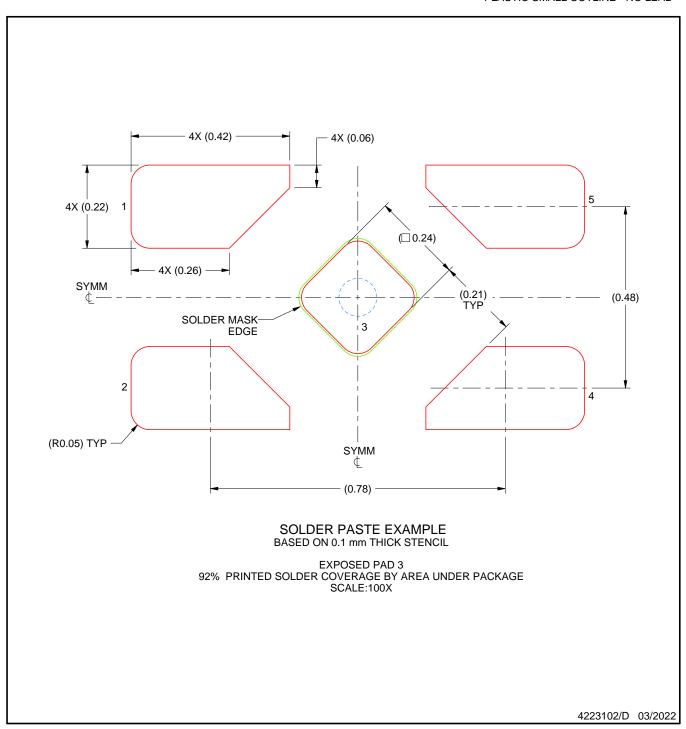




NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, refer to QFN/SON PCB application note in literature No. SLUA271 (www.ti.com/lit/slua271).





NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.







### NOTES:

- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.





NOTES: (continued)

3. Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. For more information, see Texas Instruments literature number SNVA009 (www.ti.com/lit/snva009).



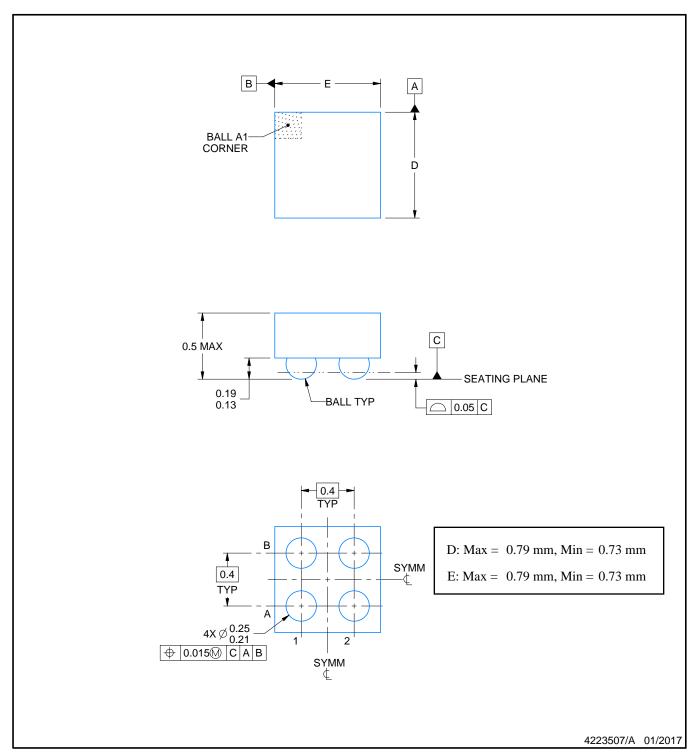


NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.



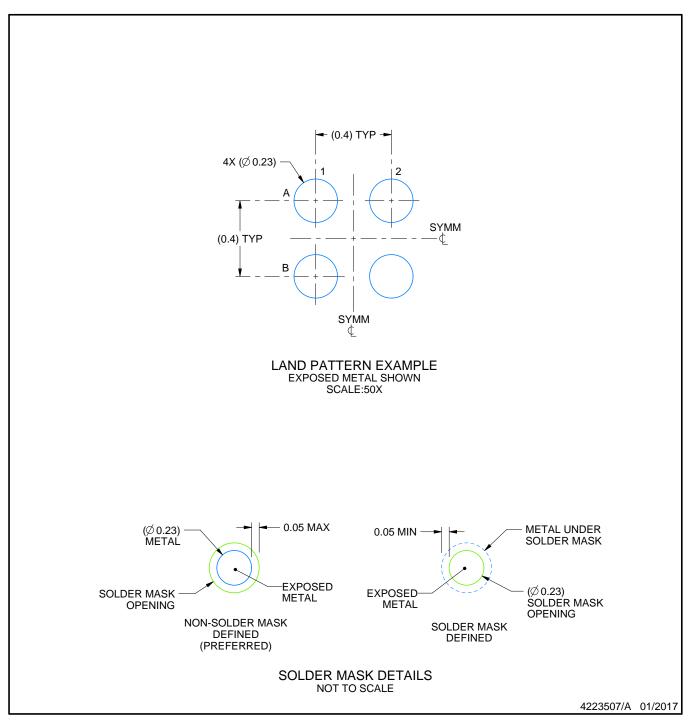




### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
  2. This drawing is subject to change without notice.

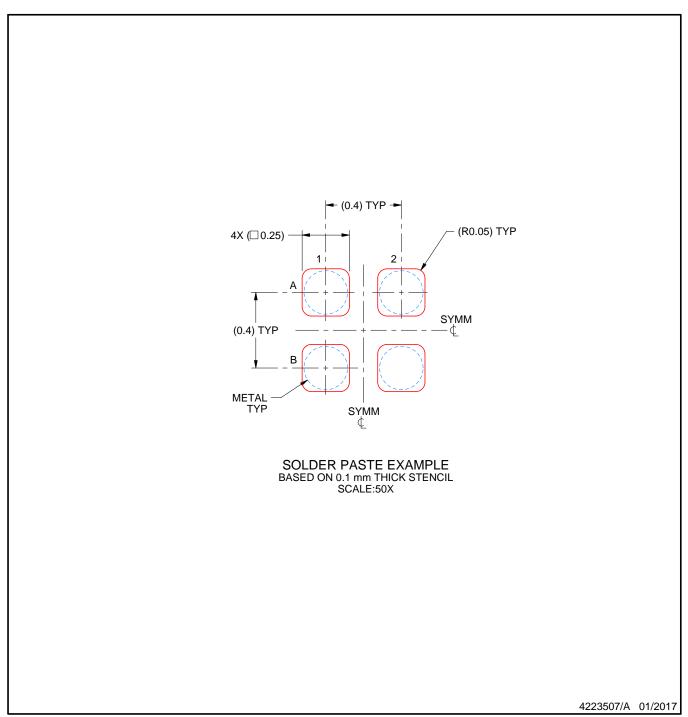




NOTES: (continued)

3. Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. For more information, see Texas Instruments literature number SNVA009 (www.ti.com/lit/snva009).





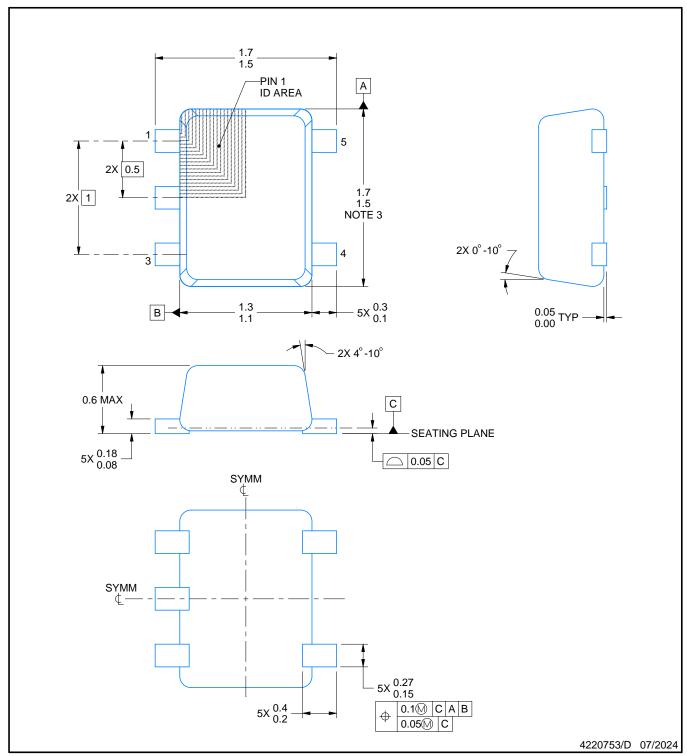
NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.





PLASTIC SMALL OUTLINE

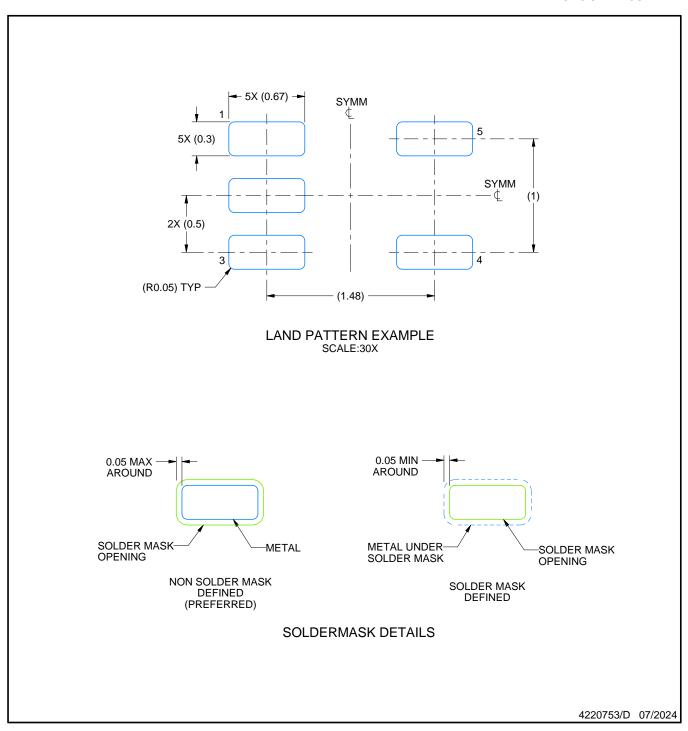


#### NOTES:

- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
   This drawing is subject to change without notice.
   This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
  4. Reference JEDEC registration MO-293 Variation UAAD-1



PLASTIC SMALL OUTLINE

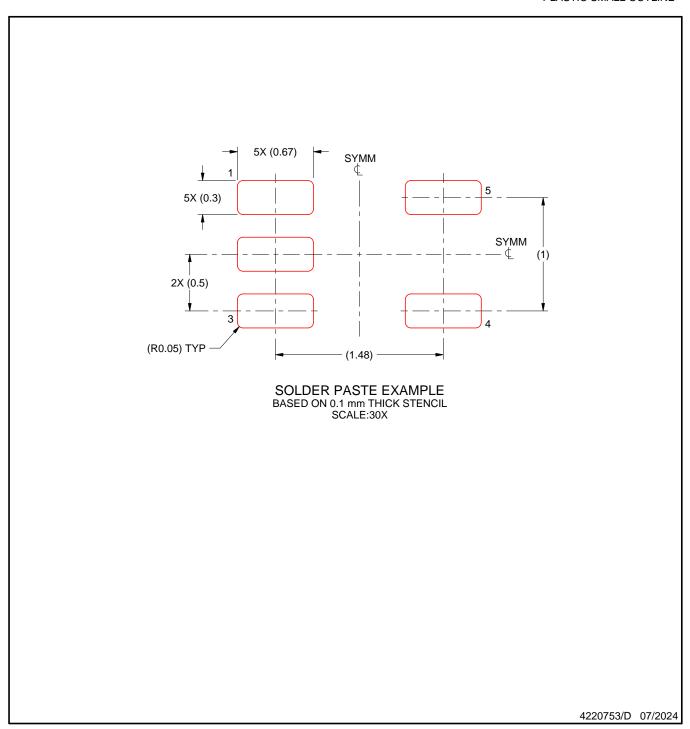


NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



PLASTIC SMALL OUTLINE



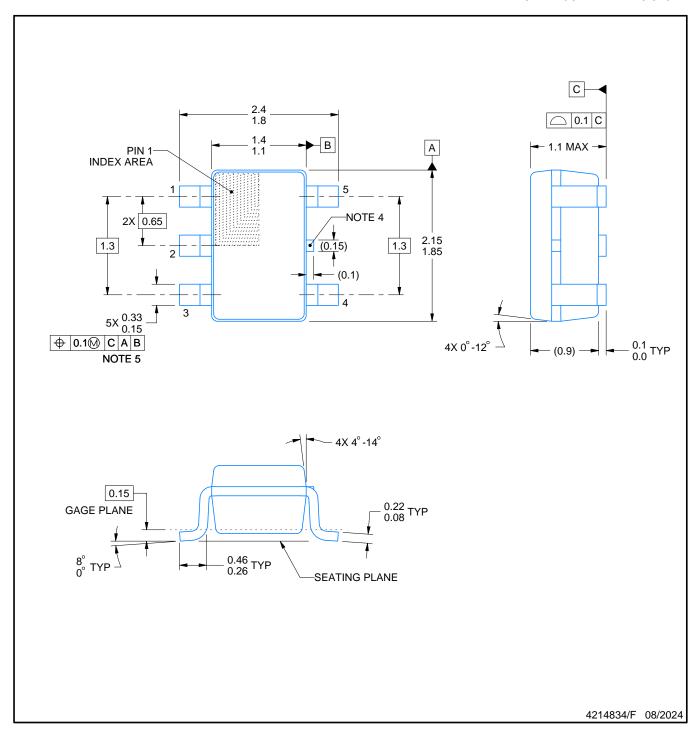
NOTES: (continued)



<sup>7.</sup> Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

<sup>8.</sup> Board assembly site may have different recommendations for stencil design.



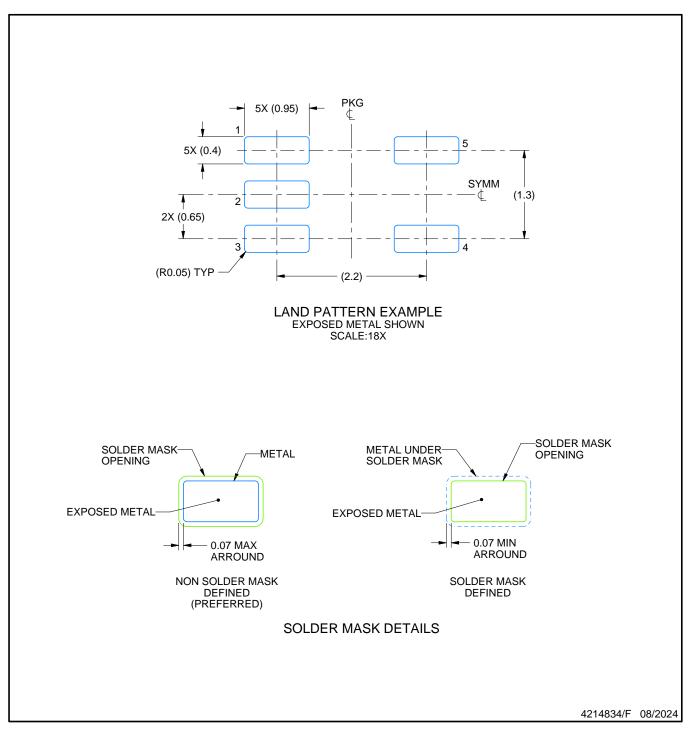


#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
  2. This drawing is subject to change without notice.
  3. Reference JEDEC MO-203.

- 4. Support pin may differ or may not be present.5. Lead width does not comply with JEDEC.
- 6. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25mm per side

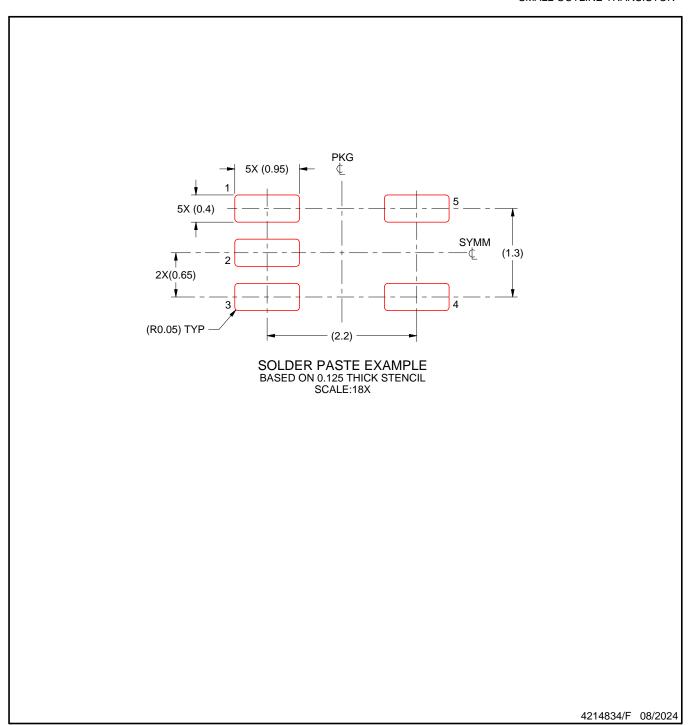




NOTES: (continued)

7. Publication IPC-7351 may have alternate designs.8. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 9. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 10. Board assembly site may have different recommendations for stencil design.



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